## Application/Control No. Applicant(s)/Patent Under Reexamination 10/646,307 BABICH ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 1752 Sin J. Lee **U.S. PATENT DOCUMENTS** Date **Document Number** Classification Name Country Code-Number-Kind Code MM-YYYY 430/315 US-6,440,642 08-2002 Shelnut et al. Α US-В С US-US-D US-Ε US-F G US-US-Н US-US-J Κ US-US-US-М **FOREIGN PATENT DOCUMENTS** Date **Document Number** Classification Name Country Country Code-Number-Kind Code MM-YYYY N o Р Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W

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